

## 350V N-Channel MOSFET

#### **General Features**

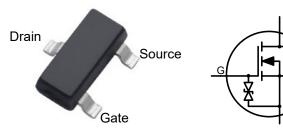
- ➤ ESD improved Capability
- Proprietary Advanced Planar Technology
- Rugged Polysilicon Gate Cell Structure
- Fast Switching Speed
- ➤ RoHS Compliant
- ➤ Halogen-free available

# **Applications**

- ➤ High Efficiency SMPS
- ➤ Adaptor/Charger
- > Active PFC

BVDSX	RDS(ON) (Max.)	ID
350V	15 Ω	200mA

SOT-23



## **Ordering Information**

Part Number	Package	Marking	Remark
FTZ15N35G	SOT-23	N35	Halogen Free

## **Absolute Maximum Ratings**

T<sub>A</sub>=25°C unless otherwise specified

Symbol	Parameter	FTZ15N35G	Unit
$V_{DSX}$	Drain-to-Source Voltage <sup>[1]</sup>	350	V
V <sub>DGX</sub>	Drain-to-Gate Voltage <sup>[1]</sup>	350	V
$I_D$	Continuous Drain Current	0.2	٨
$I_{DM}$	Pulsed Drain Current <sup>[2]</sup>	0.6	A
$P_{D}$	Power Dissipation	0.50	W
$V_{GS}$	Gate-to-Source Voltage	±20	V
V <sub>ESD(G-S)</sub>	Gate Source ESD IEC, C=150pF, R=330 Ω	200	V
$T_{ m L}$	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	$^{\circ}$
T <sub>J</sub> and T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

## **Thermal Characteristics**

Symbol	Parameter	FTZ15N35G	Unit
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient	250	K/W



## **Electrical Characteristics**

#### **OFF** Characteristics

T<sub>A</sub> =25 °C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	<b>Test Conditions</b>
$\mathrm{BV}_{\mathrm{DSX}}$	Drain-to-Source Breakdown Voltage	350			V	$V_{GS}=0V,I_D=250\mu A$
$\triangle BV_{DSS}/\triangle T_{J}$	Breakdown Voltage Temperature Coefficient		0.35		V/℃	Reference to $25^{\circ}$ C, $I_D=250\mu A$
				1	μΑ	$V_{DS}=350V$ , $V_{GS}=0V$
$I_{DSS}$	Drain-to-Source Leakage Current			100	uA	$V_{DS}$ =350V, $V_{GS}$ = 0V $T_J$ =125°C
I <sub>GSS</sub>	Gate-to-Source Leakage Current			20		V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V
				-20	uA	$V_{GS}$ =-20V, $V_{DS}$ =0V

### **ON** Characteristics

#### $T_A = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	<b>Test Conditions</b>
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance		8	15	Ω	$V_{GS}=10V$ , $I_D=200mA^{[3]}$
V <sub>GS(TH)</sub>	Gate Threshold Voltage	1		3	V	$V_{GD} = 0V, I_D = 250 \mu A$

#### **Dynamic Characteristics**

#### Essentially independent of operating temperature

					F	one of operating temperature
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
$C_{ISS}$	Input Capacitance		32.58			V <sub>GS</sub> =0V
Coss	Oput Capacitance		5.36		pF	$V_{DS}=25V$
$C_{RSS}$	Reverse Transfer Capacitance		0.75			$f=1.0MH_Z$
$t_{d(ON)}$	Turn-on Delay Time		14			
$t_{rise}$	Rise Time		10		ns	$V_{DD} = 25V, I_D=80mA$ $R_G = 25Ohm$ $V_{GS} = 10V\sim0V$
$t_{d(OFF)}$	Turn-off Delay Time		24			
$t_{\mathrm{fall}}$	Fall Time		36			

#### **Source-Drain Diode Characteristics**

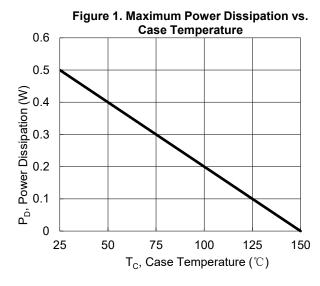
## $T_A=25^{\circ}C$ unless otherwise specified

Source Drain Blode Characteristics		1A 25 C unless otherwise specified				
Symbol	Parameter	Min	Тур.	Max.	Units	<b>Test Conditions</b>
$ m V_{SD}$	Diode Forward Voltage			1.8	V	$I_{SD} = 200 \text{ mA}, V_{GS} = 0 \text{ V}$

#### NOTE:

- [1]  $T_J = +25^{\circ}C$  to  $+150^{\circ}C$
- [2] Repetitive rating, pulse width limited by maximum junction temperature.
- [3] Pulse width \( 380 \mu s; \) duty cycle \( \le 2 \%.





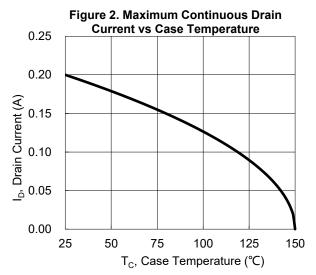
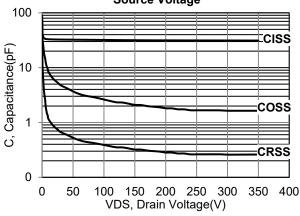
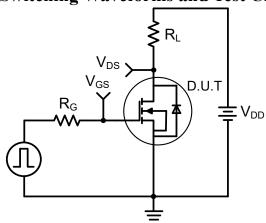


Figure 3. Typical Capacitance vs. Drain-to-Source Voltage



## **Switching Waveforms and Test Circuit**





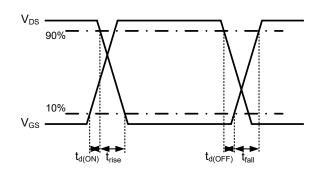
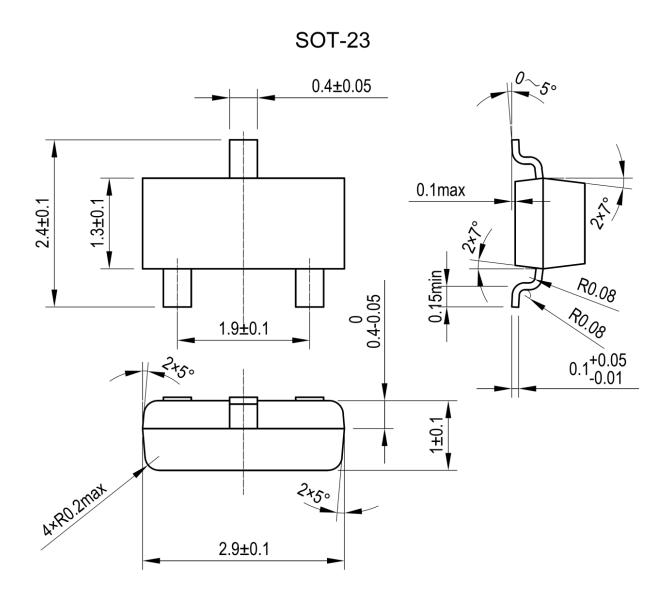


Figure 5. Resistive Switching Waveforms



# **Package Dimensions**





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